Issue	Classification

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Application No.	Applicant(s)	
09/728,297	YEN ET AL.	
Examiner	Art Unit	
Kambiz Abdi	3621	

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ŀ	Kambiz Addi 29 October 2004 (Assistant Examiner) (Date)				James P. Dammell 28 October 2004			Total Claims Allowed; 18				
(Legal Instruments Examiner) (Date)				ments Examiner) (I	Date)	(Primary Examiner) (Oste)				Print C	laim(s)	Print Fig.

Claims ren	umbered in th	ne same order as i	presented by applicant	☐ CPA	☐ T.D.	☐ R.1.47
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